

MOS FIELD EFFECT TRANSISTOR $\mu PA2590$

N- AND P-CHANNEL MOSFET FOR SWITCHING

DESCRIPTION

The μ PA2590 is N- and P-channel MOSFETs designed for DC/DC converters and power management applications of portable equipments.

N- and P-channel MOSFETs are assembled in one package, to contribute minimize the equipments.

FEATURES

- 4.5 V drive available
- Low on-state resistance

N-channel R_{DS(on)1} = 50 m Ω MAX. (V_{GS} = 10 V, I_D = 2 A)

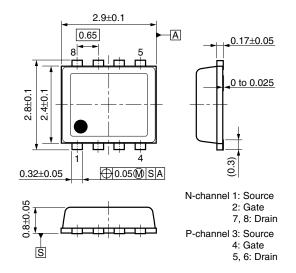
 $R_{DS(on)2}$ = 83 m Ω MAX. (Vgs = 4.5 V, ID = 2 A)

P-channel R_{DS(on)1} = 72 m Ω MAX. (VGS = -10 V, ID = -2 A)

 $R_{DS(on)2}$ = 105 m Ω MAX. (VGS = -4.5 V, ID = -2 A)

- Built-in gate protection diode
- Small and surface mount package (8-pin VSOF (2429))

PACKAGE DRAWING (Unit: mm)



ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE		
μ PA2590T1H-T1-AT Note	_	8 mm embossed taping			
μ PA2590T1H-T2-AT Note	Pure Sn	3000 p/reel	8-pin VSOF (2429)		

Note Pb-free (This product does not contain Pb in the external electrode and other parts.)

Marking: 2590

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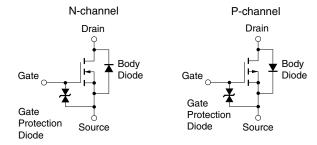
ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Drain to Source Voltage (V _{GS} = 0 V)	V _{DSS}	30	-30	V
Gate to Source Voltage (VDS = 0 V)	V _{GSS}	±20	∓20	V
Drain Current (DC)	I _{D(DC)}	±4.5	∓4.5	А
Drain Current (pulse) Note1	ID(pulse)	±18	∓18	А
Total Power Dissipation (1 unit, 5 s) Note2	P _{T1}	1.5	W	
Total Power Dissipation (2 units, 5 s) Note2	P _{T2}	1.2	W	
Channel Temperature	Tch	150	°C	
Storage Temperature	Tstg	–55 to	°C	

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on FR-4 board of 25.4 mm x 25.4 mm x 0.8 mmt

EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD.

When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

Caution This product is electrostatic-sensitive device due to low ESD capability and should be handled with caution for electrostatic discharge.



ELECTRICAL CHARACTERISTICS (TA = 25°C)

N-channel MOSFET

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30 V, V _{GS} = 0 V			1	μΑ
Gate Leakage Current	Igss	V _{GS} = ±16 V, V _{DS} = 0 V			±10	μA
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.0		2.5	V
Forward Transfer Admittance Note	y fs	V _{DS} = 10 V, I _D = 2 A	1			S
Drain to Source On-state Resistance Note	R _{DS(on)1}	V _{GS} = 10 V, I _D = 2 A		38	50	mΩ
	R _{DS(on)2}	V _{GS} = 4.5 V, I _D = 2 A		48	83	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V,		310		pF
Output Capacitance	Coss	V _{GS} = 0 V,		65		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		27		pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = 15 V, I _D = 2 A,		6		ns
Rise Time	tr	V _{GS} = 10 V,		2.8		ns
Turn-off Delay Time	t _{d(off)}	R _G = 6 Ω		15		ns
Fall Time	tf			2.4		ns
Total Gate Charge	Q _G	V _{DD} = 24 V, V _{GS} = 10 V,				_
		I _D = 4.5 A		6.6		nC
Body Diode Forward Voltage Note	V _{F(S-D)}	I _F = 4.5 A, V _{GS} = 0 V		0.9		V

Note Pulsed

TEST CIRCUIT 1 SWITCHING TIME

TEST CIRCUIT 2 GATE CHARGE

$$\begin{array}{c|c} D.U.T. & \\ \hline \\ I_G = 2 \text{ mA} \\ \hline \\ PG. & \\ \hline \\ \end{array} \begin{array}{c} S \\ 50 \Omega \\ \hline \\ \end{array} \begin{array}{c} V_{DD} \\ \hline \\ \end{array}$$

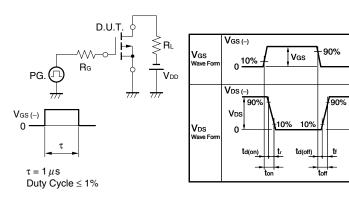


P-channel MOSFET

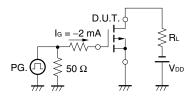
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CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = -30 V, V _{GS} = 0 V			-1	μΑ
Gate Leakage Current	Igss	V _{GS} = ∓16 V, V _{DS} = 0 V			∓10	μΑ
Gate to Source Cut-off Voltage	V _{GS(off)}	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$	1.0		2.5	V
Forward Transfer Admittance Note	yfs	V _{DS} = -10 V, I _D = -2 A	1			S
Drain to Source On-state Resistance Note	R _{DS(on)1}	V _{GS} = -10 V, I _D = -2 A		56	72	mΩ
	R _{DS(on)2}	V _{GS} = -4.5 V, I _D = -2 A		75	105	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V,		310		pF
Output Capacitance	Coss	V _{GS} = 0 V,		78		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		65		pF
Turn-on Delay Time	t _{d(on)}	$V_{DD} = -15 \text{ V}, I_D = -2 \text{ A},$		6.5		ns
Rise Time	tr	V _{GS} = -10 V,		3.5		ns
Turn-off Delay Time	t _{d(off)}	R _G = 6 Ω		33		ns
Fall Time	tf			26		ns
Total Gate Charge	Q _G	$V_{DD} = -24 \text{ V}, V_{GS} = -10 \text{ V},$				
		I _D = -4.5 A		7.5		nC
Body Diode Forward Voltage Note	V _{F(S-D)}	I _F = -4.5 A, V _{GS} = 0 V		0.95		V

Note Pulsed

TEST CIRCUIT 1 SWITCHING TIME



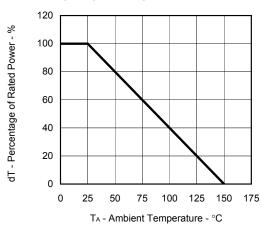
TEST CIRCUIT 2 GATE CHARGE



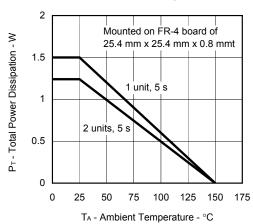
TYPICAL CHARACTERISTICS (TA = 25°C)

(1) N-channel MOSFET

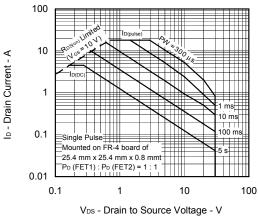




TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE

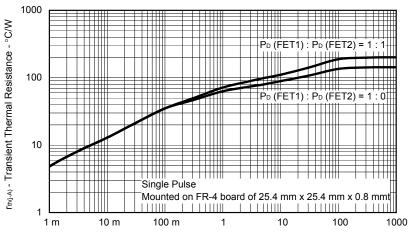


FORWARD BIAS SAFE OPERATING AREA



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TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



PW - Pulse Width - s

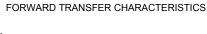
Data Sheet G19217EJ1V0DS

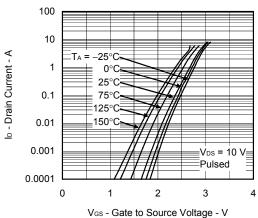
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| y_{fs} | - Forward Transfer Admittance - S

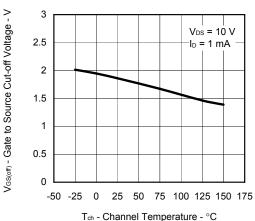
DRAIN TO SOURCE VOLTAGE 18 16 10 V 14 Ip - Drain Current - A 12 $V_{GS} = 4.5 V$ 10 8 6 4 2 Pulsed 0 0 0.4 8.0 1.2 1.6 2 VDS - Drain to Source Voltage - V

DRAIN CURRENT vs.

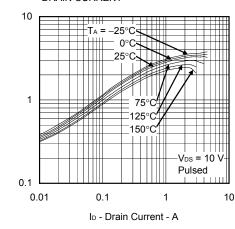




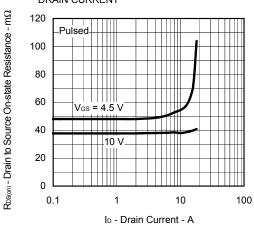
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



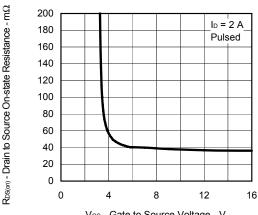
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

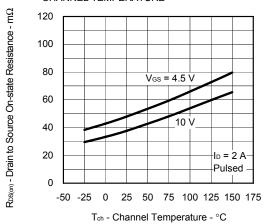


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

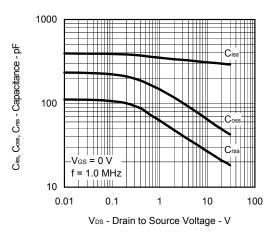


V_{GS} - Gate to Source Voltage - V

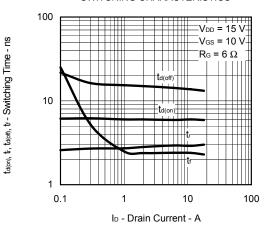
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



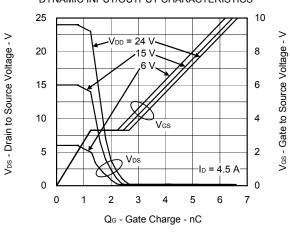
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



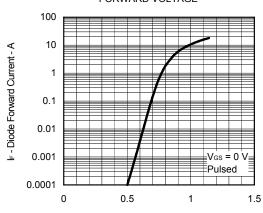
SWITCHING CHARACTERISTICS



DYNAMIC INPUT/OUTPUT CHARACTERISTICS

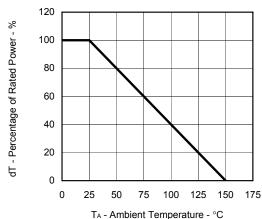


SOURCE TO DRAIN DIODE FORWARD VOLTAGE

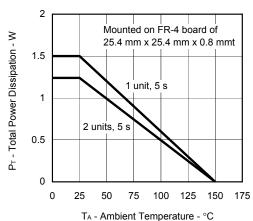


(2) P-channel MOSFET

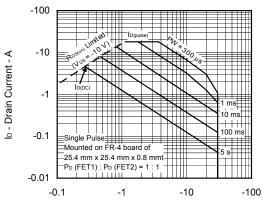
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE



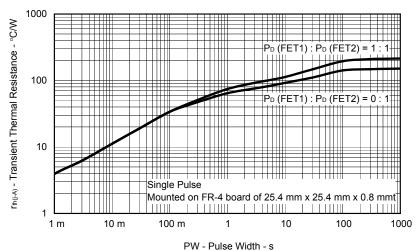
FORWARD BIAS SAFE OPERATING AREA



ONWARD BIAG GALL OF LIVATING ARLA

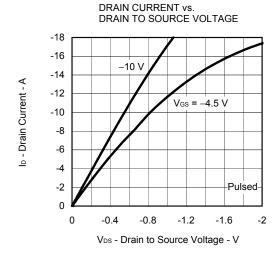
 $V_{\text{\scriptsize DS}}$ - Drain to Source Voltage - V

TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

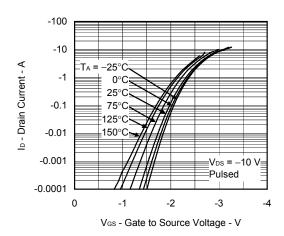


8 Data Sheet G19217EJ1V0DS

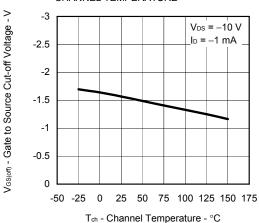
| yfs | - Forward Transfer Admittance - S



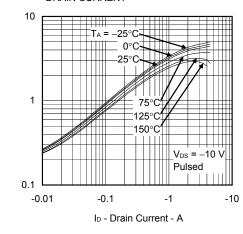
FORWARD TRANSFER CHARACTERISTICS



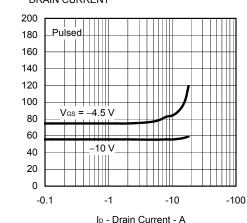
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



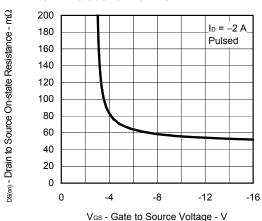
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

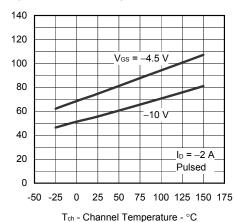


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



R_{DS(on)} - Drain to Source On-state Resistance - mΩ

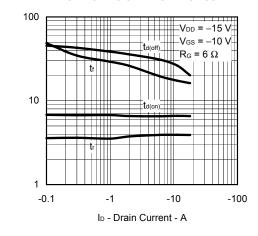
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



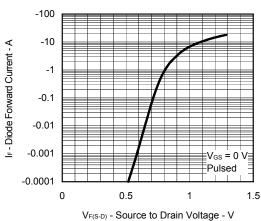
R_{DS(on)} - Drain to Source On-state Resistance - mΩ

td(on), tr, td(off), tr - Switching Time - ns

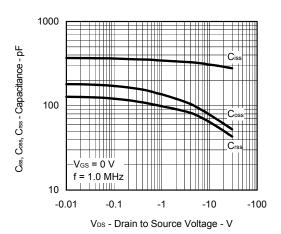
SWITCHING CHARACTERISTICS



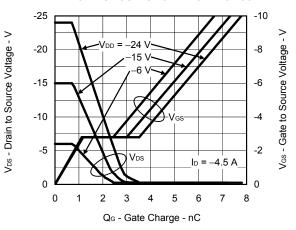
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



10

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